

**Search Notes****Application/Control No.**

10/767,774

**Examiner**

Brian Young

**Applicant(s)/Patent under Reexamination**

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**Art Unit**

2819

**SEARCHED**

Class	Subclass	Date	Examiner
341	143	2/28/2005	BY
	144		BY
	145		BY
	150		BY
	153		BY
	154		BY
✓	148		BY
✓	133	✓	BY

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST JPO,EPO,DERWENT, etc. NPL IEEE, PORTAL	2/28/2005	BY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
341	144	2/28/2005	BY
341	143	/	BY